



SLOVENSKI STANDARD
SIST EN 60122-1:2004/A1:2018
01-junij-2018

Kristalne enote določene kakovosti - 1. del: Rodovna specifikacija - Dopolnilo A1

Quartz crystal units of assessed quality - Part 1: Generic specification

Schwingquarze mit bewerteter Qualität - Teil 1: Fachgrundspezifikation

Résonateurs à quartz sous assurance de la qualité - Partie 1: Spécification générique

Ta slovenski standard je istoveten z: EN 60122-1:2002/A1:2018

[SIST EN 60122-1:2004/A1:2018](https://standards.iteh.ai/catalog/standards/sist/1956c916-513d-427f-aa7f-212f8af626db/sist-en-60122-1-2004-a1-2018)

<https://standards.iteh.ai/catalog/standards/sist/1956c916-513d-427f-aa7f-212f8af626db/sist-en-60122-1-2004-a1-2018>

ICS:

31.140 Piezoelektrične naprave Piezoelectric devices

SIST EN 60122-1:2004/A1:2018 en

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EUROPEAN STANDARD

EN 60122-1:2002/A1

NORME EUROPÉENNE

EUROPÄISCHE NORM

March 2018

ICS 31.140

English Version

Quartz crystal units of assessed quality - Part 1: Generic
specification
(IEC 60122-1:2002/A1:2017)

Résonateurs à quartz sous assurance de la qualité - Partie
1: Spécification générique
(IEC 60122-1:2002/A1:2017)

Schwingquarze mit bewerteter Qualität - Teil 1:
Fachgrundspezifikation
(IEC 60122-1:2002/A1:2017)

This amendment A1 modifies the European Standard EN 60122-1:2002; it was approved by CENELEC on 2018-01-12. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this amendment the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the CEN-CENELEC Management Centre or to any CENELEC member.

This amendment exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the CEN-CENELEC Management Centre has the same status as the official versions.

SIST EN 60122-1:2004/A1:2018

CENELEC members are the national electrotechnical committees of Austria, Belgium, Bulgaria, Croatia, Cyprus, the Czech Republic, Denmark, Estonia, Finland, Former Yugoslav Republic of Macedonia, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Latvia, Lithuania, Luxembourg, Malta, the Netherlands, Norway, Poland, Portugal, Romania, Serbia, Slovakia, Slovenia, Spain, Sweden, Switzerland, Turkey and the United Kingdom.



European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Rue de la Science 23, B-1040 Brussels

EN 60122-1:2002/A1:2018 (E)**European foreword**

The text of document 49/1254/FDIS, future edition 1 of IEC 60122-1:2002/A1, prepared by IEC/TC 49 "Piezoelectric and dielectric devices for frequency control and selection" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 60122-1:2002/A1:2018.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2018-10-12
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2021-01-12

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. CENELEC shall not be held responsible for identifying any or all such patent rights.

Endorsement notice

The text of the International Standard IEC 60122-1:2002/A1:2017 was approved by CENELEC as a European Standard without any modification.

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Replace Annex ZA of EN 60122-1:2002 by the following one:

Annex ZA
(normative)

**Normative references to international publications
with their corresponding European publications**

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 Where an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60027	series	Letter symbols to be used in electrical technology - Part 1: General	60027	series
IEC 60050-561	1991	International Electrotechnical Vocabulary (IEV) - Chapter 561: Piezoelectric devices for frequency control and selection	-	-
IEC 60068-1	1988	Environmental testing - Part 1: General and guidance	-	-
IEC 60068-2-1	1990	Environmental testing - Part 2: Tests - Tests A: Cold	-	-
IEC 60068-2-2	1974	Environmental testing - Part 2: Tests - Tests B: Dry heat	-	-
IEC 60068-2-3	1969	Basic environmental testing procedures - Part 2: Tests - Test Ca: Damp heat, steady state	-	-
IEC 60068-2-6	1995	Environmental testing -- Part 2: Tests - Test Fc: Vibration (sinusoidal)	-	-
IEC 60068-2-7	1983	Basic environmental testing procedures - Part 2-7: Tests - Test Ga and guidance: Acceleration, steady state	EN 60068-2-7	1993
IEC 60068-2-13	1983	Basic environmental testing procedures - Part 2-13: Tests - Test M: Low air pressure	EN 60068-2-13	1999
IEC 60068-2-14	1984	Environmental testing - Part 2: Tests - Test N: Change of temperature	-	-
IEC 60068-2-17	1994	Basic environmental testing procedures - Part 2-17: Tests - Test Q: Sealing	EN 60068-2-17	1994
IEC 60068-2-20	1979	Environmental testing - Part 2: Tests - Test T: Soldering	-	-
IEC 60068-2-21	1999	Environmental testing - Part 2-21: Tests - Test U: Robustness of terminations and integral mounting devices	-	-
IEC 60068-2-27	1987	Basic environmental testing procedures - Part 2: Tests - Test Ea and guidance: Shock	-	-

EN 60122-1:2002/A1:2018 (E)

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60068-2-29	1987	Environmental testing - Part 2: Tests - Test-Eb and guidance: Bump	-	-
IEC 60068-2-30	1980	Basic environmental testing procedures. Part 2: Tests. Test Db and guidance: Damp heat, cyclic (12 + 12-hour cycle)	-	-
IEC 60068-2-32	1975	Basic environmental testing procedures - Part 2: Tests - Test Ed: Free fall	-	-
IEC 60068-2-45	1980	Basic environmental testing procedures - Part 2-45: Tests - Test XA and guidance: Immersion in cleaning solvents	EN 60068-2-45	1992
IEC 60122-3	2001	Quartz crystal units of assessed quality - Part 3: Standard outlines and lead connections	-	-
IEC 60444-1	1986	Measurement of quartz crystal unit parameters by zero phase technique in a pi-network - Part 1: Basic method for the measurement of resonance frequency and resonance resistance of quartz crystal units by zero phase technique in a pi-network	EN 60444-1	1997
IEC 60444-2	1980	Measurement of quartz crystal unit parameters by zero phase technique in a pi-network - Part 2: Phase offset method for measurement of motional capacitance of quartz crystal units	EN 60444-2	1997
IEC/TR 60444-4	1988	Measurement of quartz crystal unit parameters by zero phase technique in a pi-network - Part 4: Method for the measurement of the load resonance frequency f _L , load resonance resistance R _L and the calculation of other derived values of quartz crystal units, up to 30 MHz	EN 60444-4	1997
IEC 60444-5	1995	Measurement of quartz crystal unit parameters - Part 5: Methods for the determination of equivalent electrical parameters using automatic network analyzer techniques and error correction	EN 60444-5	1997
IEC 60444-6	1995	Measurement of quartz crystal unit parameters - Part 6: Measurement of drive level dependence (DLD)	-	-
IEC 60617	series	Graphical symbols for diagrams - Part 1: General information, general index, Cross-reference tables	EN 60617	series
IEC 61178-2	1993	Quartz crystal units - A specification in the IEC Quality Assessment System for electronic Components (IECQ) - Part 2: Sectional specification - Capability approval	-	-

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 61178-3	1993	Quartz crystal units - A specification in the IEC Quality Assessment System for electronic Components (IECQ) - Part 3: Sectional specification - Qualification approval	-	-
IEC 61760-1	2006	Surface mounting technology - Part 1: Standard method for the specification of surface mounting components (SMDs)	EN 61760-1	2006
IEC QC 001001	2000	IEC Quality Assessment System for Electronic Components (IECQ) - Basic rules	-	-
IEC QC 001002-2	1998	IEC Quality Assessment System for Electronic Components (IECQ) - Rules of Procedure -- Part 2: Documentation	-	-
IEC QC 001002-3	1998	IEC Quality Assessment System for Electronic Components (IECQ) - Rules of Procedure - Part 3: Approval procedures	-	-
IEC QC 001005	2000	Register of firms, products and services approved under the IECQ system, including ISO 9000	-	-
ISO 1000	1992	SI units and recommendations for the use of their multiples and of certain other units	-	-

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INTERNATIONAL STANDARD

AMENDMENT 1

Quartz crystal units of assessed quality –
Part 1: Generic specification

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